

# N-Channel 100 V (D-S) MOSFET

	PRODUCT SUMMARY							
V <sub>DS</sub> (V)		$R_{DS(on)}(m\Omega)$ Max.	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)				
Ī	100	6.2 at V <sub>GS</sub> = 10 V	55	40 nC				
		10.8 at $V_{GS} = 4.5 \text{ V}$	40	40 HC				

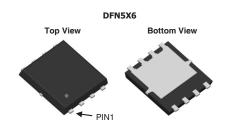
#### **FEATURES**

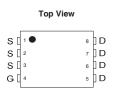


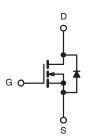
- TrenchFET IIPower MOSFET
- 100 % Rgand UIS Tested

#### **APPLICATIONS**

- DC/DC Primary Side Switch
- Telecom/Server 48 V, Full/Half-Bridge DC/DC







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS Parameter	· //	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	100			
Gate-Source Voltage	V <sub>GS</sub>	± 20	V		
	T <sub>C</sub> = 25 °C		55		
Continuous Drain Current (T <sub>.I</sub> = 150 °C)	$T_C = 70  ^{\circ}C$	I <sub>D</sub>	40		
Continuous Brain Current (1) = 100 °C)	T <sub>A</sub> = 25 °C	υ,	17.9 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		14.7 <sup>b, c</sup>	A	
Pulsed Drain Current (t = 300 μs)		I <sub>DM</sub>	240	7 ^	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I-	60		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	4.9 <sup>b, c</sup>		
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	45		
Single Pulse Avalanche Energy	L = 0.1 IIII1	E <sub>AS</sub>	61	mJ	
	T <sub>C</sub> = 25 °C		115		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	73	w	
Maximum Fower Dissipation	T <sub>A</sub> = 25 °C	' В	5.9 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		4.1 <sup>b, c</sup>		
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature		260			

THERMAL RESISTANCE RATINGS								
Parameter	Symbol	Typical	Maximum	Unit				
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s	R <sub>thJA</sub>	20	22	°C/W			
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	2.1	2.5	O/ VV			

#### Notes:

- a. Based on T<sub>C</sub> = 25 °C.
  b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
  d. The DFN5X6 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 70 °C/W.

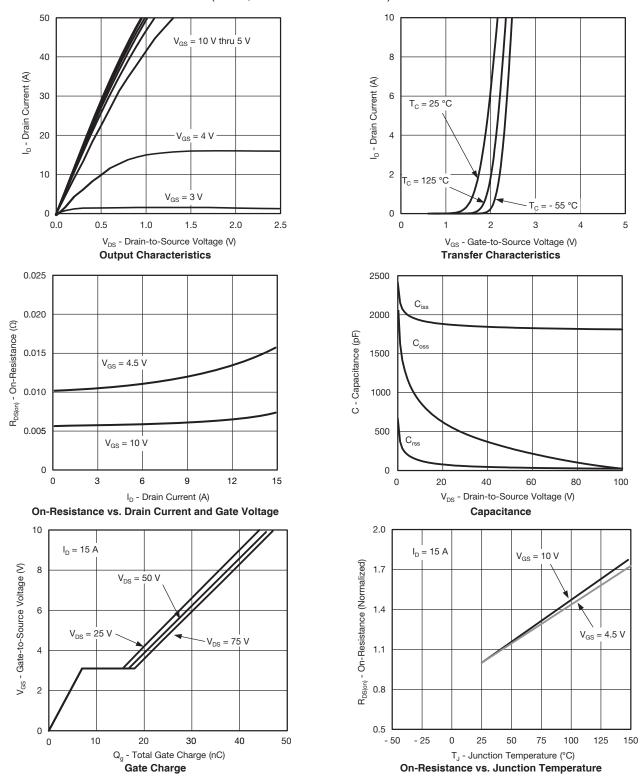
Parameter	Symbol Test Conditions		Min.	Тур.	Max.	Unit
Static						
rain-Source Breakdown Voltage V <sub>DS</sub>		$V_{GS} = 0$ , $I_D = 250 \mu A$	100			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		64		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	10 = 200 μΛ		- 5.8		11107
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0		3.0	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V			1	μΑ
Zero Gate Voltage Drain Gurrent		$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	55			Α
Ducin Course On State Decistor A	Basi	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A		0.0062	0.0078	0
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 10 A		0.0105	0.0159	Ω
Forward Transconductance <sup>a</sup> 9 <sub>fs</sub>		V <sub>DS</sub> = 10 V, I <sub>D</sub> = 15 A		65		S
Dynamic <sup>b</sup>	•					
Input Capacitance	C <sub>iss</sub>			1790		pF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 0 V, f = 1 MHz		178		
Reverse Transfer Capacitance	C <sub>rss</sub>			35		
Total Cata Chaves	Qg	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}$		40		nC
Total Gate Charge				27		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 50 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		6.1		
Gate-Drain Charge	$Q_{gd}$			8.2		
Gate Resistance	R <sub>g</sub> f = 1 MHz		0.2	1.25	2.5	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			18		
Rise Time	t <sub>r</sub>	$V_{DD} = 50 \text{ V}, R_L = 5 \Omega$		10		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		25		ns
Fall Time t <sub>f</sub>				7		1
<b>Drain-Source Body Diode Characteristic</b>	s					
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			55	A
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				200	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 4 A		0.7	1.1	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			56		ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 10 A, dl/dt = 100 A/μs, T <sub>.I</sub> = 25 °C		38		nC
Reverse Recovery Fall Time	ta	$i_F = 10 \text{ A}$ , $u_i/u_i = 100 \text{ A/}\mu \text{s}$ , $i_J = 25 \text{ C}$		22		nc
Reverse Recovery Rise Time	t <sub>b</sub>			15		ns

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.

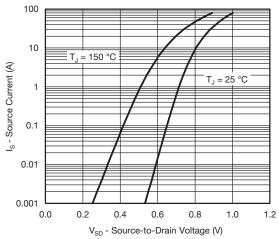


## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

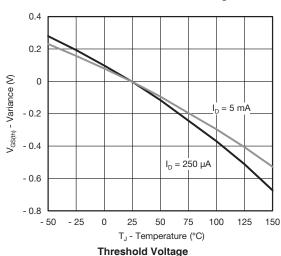




# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

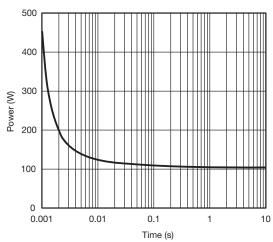


#### Source-Drain Diode Forward Voltage

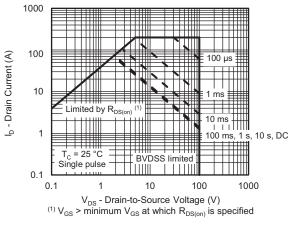


O.05 O.04 O.04 O.05 O.04 O.05 O.05 O.05 O.05 O.05 O.00 O.00

On-Resistance vs. Gate-to-Source Voltage

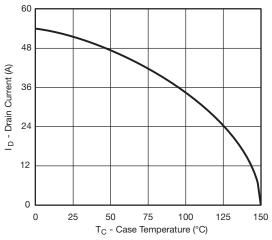


Single Pulse Power, Junction-to-Ambient

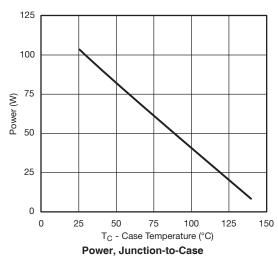


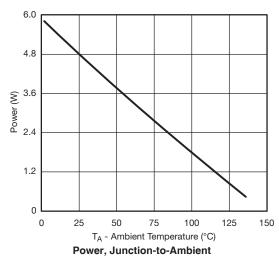
Safe Operating Area

## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



#### Current Derating\*

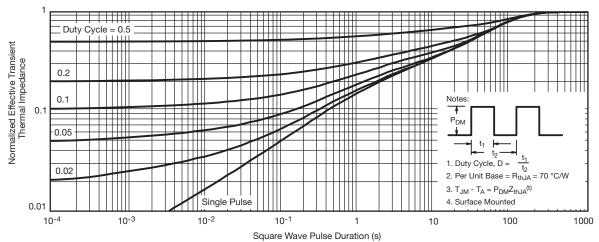




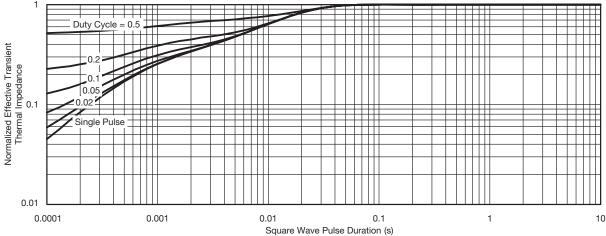
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

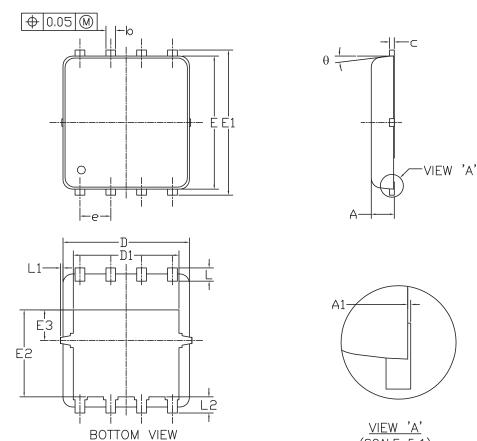


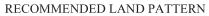
Normalized Thermal Transient Impedance, Junction-to-Ambient

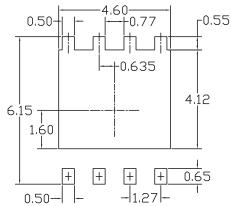


Normalized Thermal Transient Impedance, Junction-to-Case

## DFN5x6\_8L\_EP1\_P PACKAGE OUTLIN







SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
31 MBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
A	0.85	0. 95	1.00	0.033	0.037	0.039	
A1	0.00		0.05	0.000		0.002	
b	0.30	0.40	0.50	0.012	0.016	0.020	
С	0.15 0.20		0. 25	0.006	0.008	0.010	
D	4. 80	5. 20	5. 30	0. 201	0. 205	0. 209	
D1	4. 25	4. 35	4. 45	0. 167	0.171	0. 175	
Е	5. 45	5. 55	5. 65	0. 215	0. 219	0. 222	
E1	5. 95	6.05	6. 15	0. 234	0. 238	0. 242	
E2	3. 525	3. 625	3. 725	0.139	0.143	0.147	
E3	1. 175 1. 275		1.375	0.046	0.050	0.054	
e	1. 27 BSC			0.050 BSC			
L	0.45	0. 55	0.65	0.018	0.022	0.026	
L1	0		0.15	0		0.006	
L2	0.68 REF			0.027 REF			
θ	0°		10°	0°		10°	

(SCALE 5:1)

# NOTE UNIT: mm

- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.





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